

**GM9452**

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

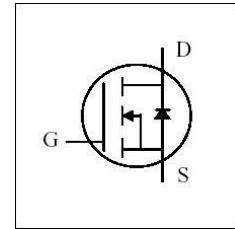
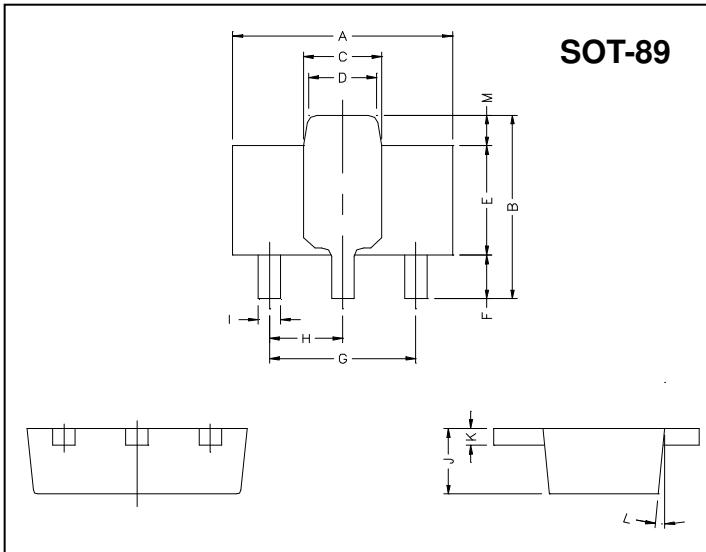
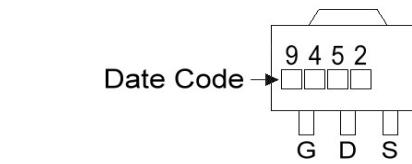
BVDSS	20V
RDS(ON)	50mΩ
ID	4A

**Description**

The GM9452 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

**Features**

- \*Simple Drive Requirement
- \*Low Gate Charge
- \*Capable of 2.5V Gate Drive

**Package Dimensions****Marking :**

REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.4	4.6	G	3.00	REF.
B	4.05	4.25	H	1.50	REF.
C	1.50	1.70	I	0.40	0.52
D	1.30	1.50	J	1.40	1.60
E	2.40	2.60	K	0.35	0.41
F	0.89	1.20	L	5° TYP.	
			M	0.70 REF.	

**Absolute Maximum Ratings**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	20	V
Gate-Source Voltage	V <sub>GS</sub>	±16	V
Continuous Drain Current <sup>3</sup> , V <sub>GS</sub> @4.5V	I <sub>D</sub> @T <sub>A</sub> =25°C	4	A
Continuous Drain Current <sup>3</sup> , V <sub>GS</sub> @4.5V	I <sub>D</sub> @T <sub>A</sub> =70°C	2.5	A
Pulsed Drain Current <sup>1</sup>	I <sub>DM</sub>	12	A
Total Power Dissipation	P <sub>D</sub> @T <sub>A</sub> =25°C	1.25	W
Linear Derating Factor		0.01	W/°C
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 ~ +150	°C

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient <sup>3</sup> Max.	R <sub>thj-a</sub>	100	°C/W

## Electrical Characteristics( $T_j = 25^\circ\text{C}$ Unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	20	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	0.03	-	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	0.7	-	1.5	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$
Forward Transconductance <sup>2</sup>	$\text{g}_{\text{fs}}$	-	10	-	S	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=3\text{A}$
Gate-Source Leakage Current	$\text{I}_{\text{GSS}}$	-	-	$\pm 100$	nA	$\text{V}_{\text{GS}}= \pm 16\text{V}$
Drain-Source Leakage Current( $T_j=25^\circ\text{C}$ )	$\text{I}_{\text{DSS}}$	-	-	1	$\mu\text{A}$	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source Leakage Current( $T_j=70^\circ\text{C}$ )		-	-	25	$\mu\text{A}$	$\text{V}_{\text{DS}}=16\text{V}, \text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance <sup>2</sup>	$\text{R}_{\text{DS}(\text{ON})}$	-	-	38	$\text{m}\Omega$	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=4\text{A}$
		-	-	50		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=4\text{A}$
Total Gate Charge <sup>2</sup>	$\text{Q}_g$	-	6	10	nc	$\text{I}_D=4\text{A}$ $\text{V}_{\text{DS}}=16\text{V}$ $\text{V}_{\text{GS}}=4.5\text{V}$
Gate-Source Charge	$\text{Q}_{\text{gs}}$	-	1	-		
Gate-Drain ("Miller") Change	$\text{Q}_{\text{gd}}$	-	2	-		
Turn-on Delay Time <sup>2</sup>	$\text{T}_{\text{d}(\text{on})}$	-	8	-	ns	$\text{V}_{\text{DS}}=10\text{V}$ $\text{I}_D=1\text{A}$ $\text{V}_{\text{GS}}=5\text{V}$ $\text{R}_G=3.3\Omega$ $\text{R}_D=10\Omega$
Rise Time	$\text{T}_r$	-	9	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	13	-		
Fall Time	$\text{T}_f$	-	3	-		
Input Capacitance	$\text{C}_{\text{iss}}$	-	360	570	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=20\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	$\text{C}_{\text{oss}}$	-	80	-		
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$	-	65	-		

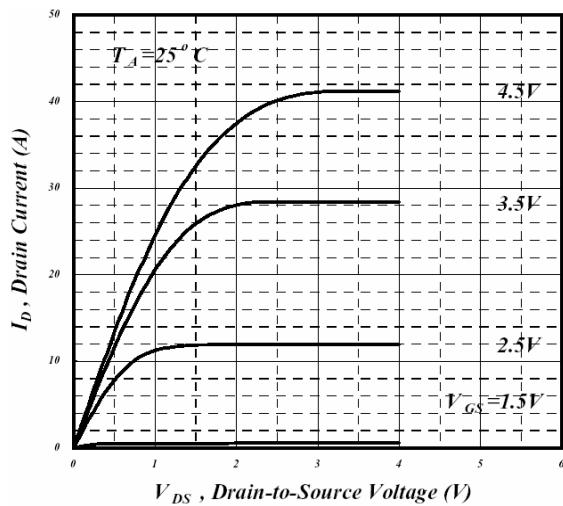
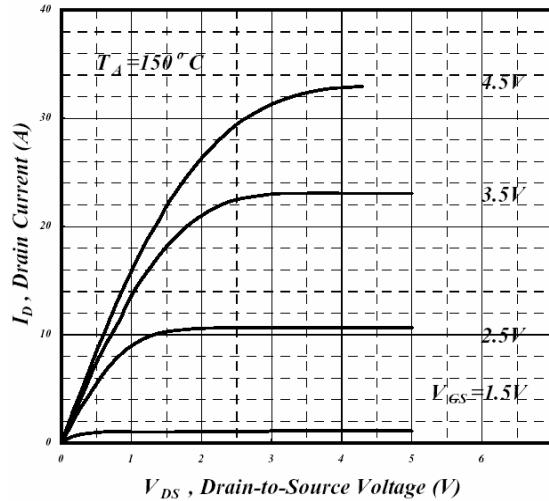
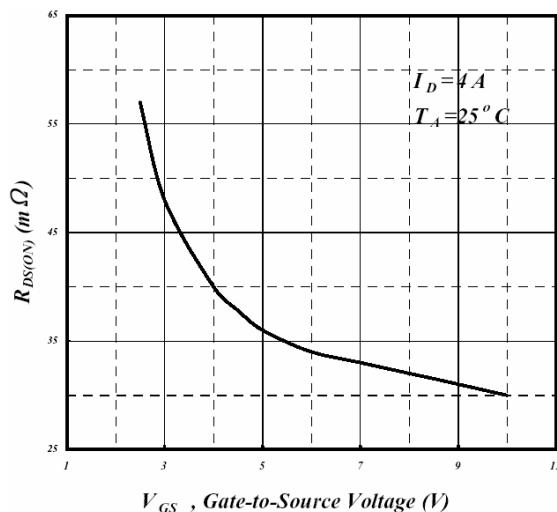
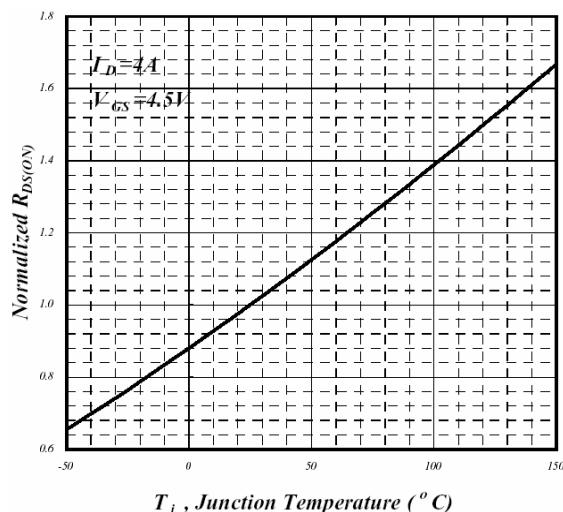
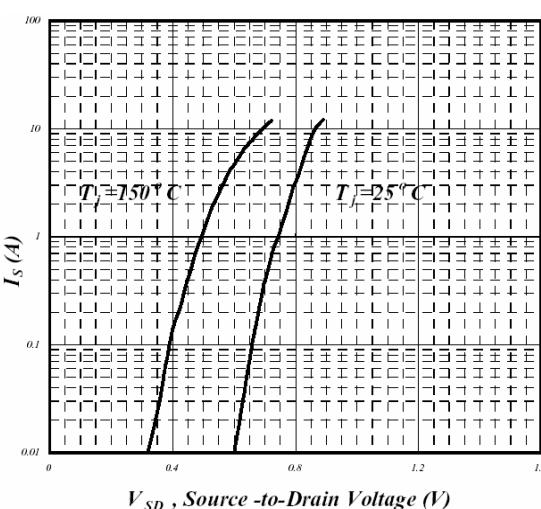
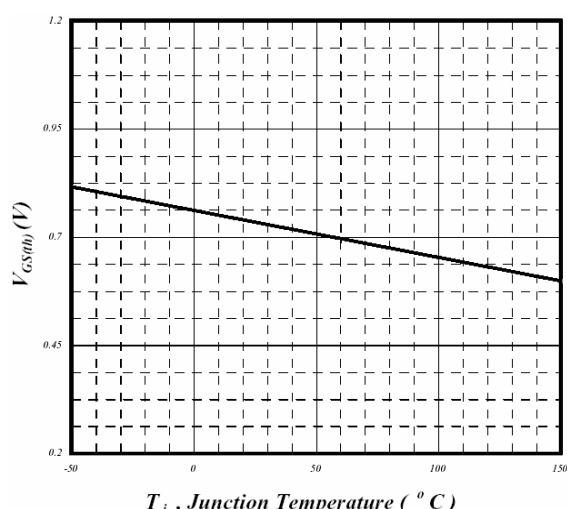
## Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage <sup>2</sup>	$\text{V}_{\text{SD}}$	-	-	1.3	V	$\text{I}_S=1\text{A}, \text{V}_{\text{GS}}=0\text{V}$
Reverse Recovery Time <sup>2</sup>	$\text{T}_{\text{rr}}$	-	18	-	ns	$\text{I}_S=4\text{A}, \text{V}_{\text{GS}}=0\text{V}$
Reverse Recovery Charge	$\text{Q}_{\text{rr}}$	-	10	-	nC	$d\text{I}/dt=100\text{A}/\mu\text{s}$

Notes: 1. Pulse width limited by safe operating area.

2. Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

3. Surface mounted on FR4 board,  $t \leq 10\text{sec}$ .

**Characteristics Curve****Fig 1. Typical Output Characteristics****Fig 2. Typical Output Characteristics****Fig 3. On-Resistance v.s. Gate Voltage****Fig 4. Normalized On-Resistance v.s. Junction Temperature****Fig 5. Forward Characteristics of Reverse Diode****Fig 6. Gate Threshold Voltage v.s. Junction Temperature**

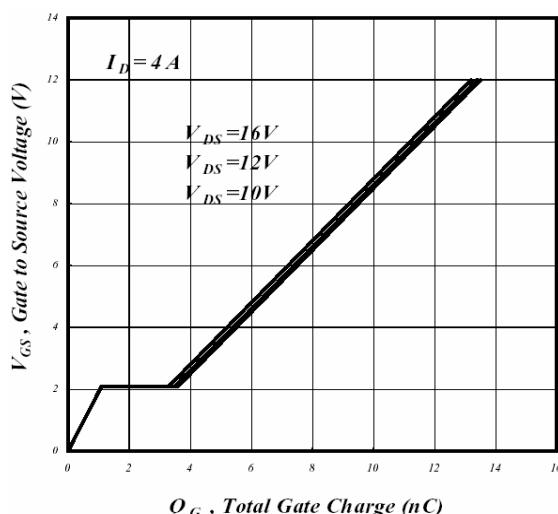


Fig 7. Gate Charge Characteristics

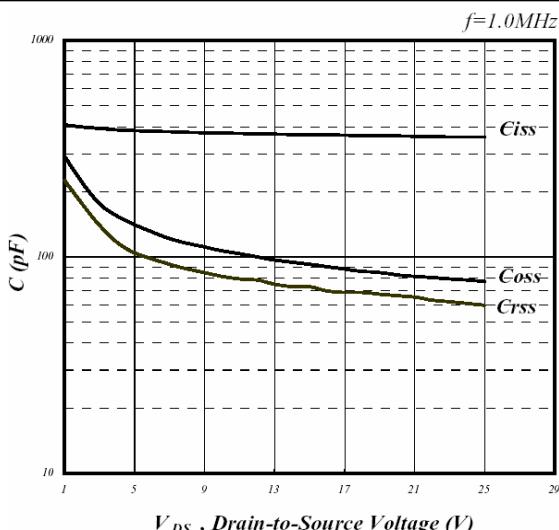


Fig 8. Typical Capacitance Characteristics

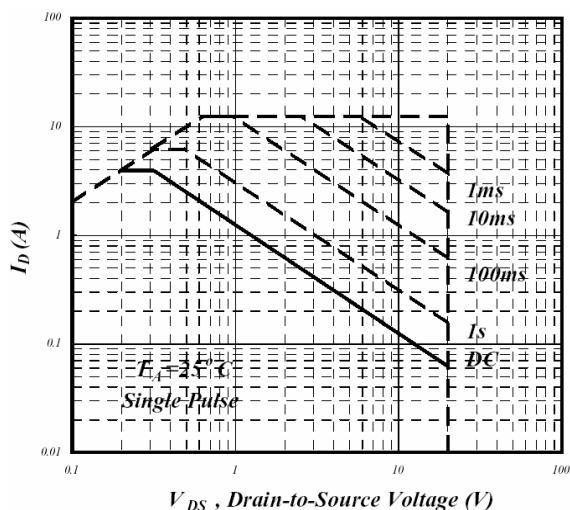


Fig 9. Maximum Safe Operating Area

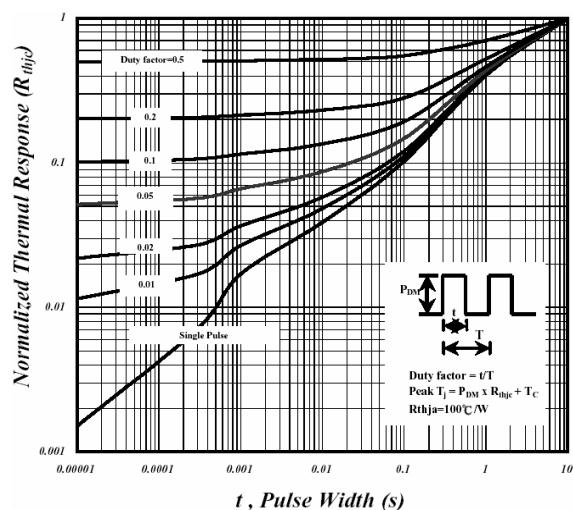


Fig 10. Effective Transient Thermal Impedance

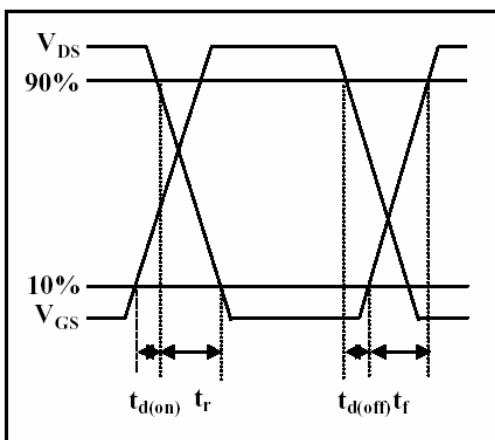


Fig 11. Switching Time Waveform

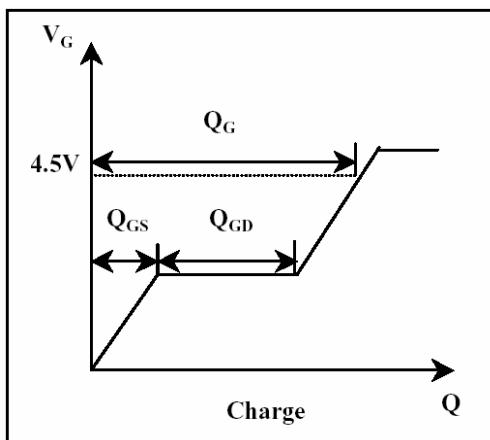


Fig 12. Gate Charge Waveform

**Important Notice:**

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of GTM.
  - GTM reserves the right to make changes to its products without notice.
  - GTM semiconductor products are not warranted to be suitable for use in life-support Applications, or systems.
  - GTM assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.
- Head Office And Factory:**
- Taiwan:** No. 17-1 Tatung Rd. Fu Kou Hsin-Chu Industrial Park, Hsin-Chu, Taiwan, R. O. C.  
TEL : 886-3-597-7061 FAX : 886-3-597-9220, 597-0785
  - China:** (201203) No.255, Jiang-Jiang Tsai-Lueng RD. , Pu-Dung-Hsin District, Shang-Hai City, China  
TEL : 86-21-5895-7671 ~ 4 FAX : 86-21-38950165